



Electronics

Research & development

With a TAGARNO microscope

Results

Digitalize First article inspection

Include measurements and photos in the First article inspection (FAI) report

With a digital microscope, you can measure the distance between two components directly on the microscope. Capture an image of the measurement and forward it to those involved in the FAI to avoid sending the ordered product back and forth. Everything is on the photos.

With Focus stacking app, you can stack images captured at different focus heights on top of each other. No more photos with blurred areas!

Lastly, importing a DXF file of the ordered product to the microscope and superimposing it on the microscope live image will verify that

each component has been placed as specified. The more documentation you can provide, the better — and with a digital microscope, this process is now a whole lot easier.

“
**Saving images is easy
and has **simplified** our
processes**”

The perfect package for

Research & development

Microscope



Accessories

Ring light (white)
View every little detail

Lens 1x Plan
Magnify at the right level



Apps



Measurement
Measure distances, angles, diameters and more



Focus stacking
Create ultra-sharp images with no blurred or out of focus areas



DXF overlay
Find small PCB components with search bar



Our employees chose the TAGARNO because of its user friendliness

Loïc Boutillier, Technician Methods
ALL CIRCUITS, France

Contact

Want to know more?

Take a look at tagarno.com or contact your local TAGARNO distributor if you want to see how you can optimize processes and improve quality.

tagarno.com

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